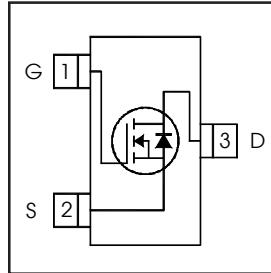


IRLML2030TRPbF

HEXFET® Power MOSFET

V_{DS}	30	V
V_{GS Max}	± 20	V
R_{DS(on) max} (@V _{GS} = 10V)	100	mΩ
R_{DS(on) max} (@V _{GS} = 4.5V)	154	mΩ



Micro3™ (SOT-23)
IRLML2030TRPbF

Application(s)

- Load/ System Switch

Features and Benefits

Features

Industry-standard pinout
Compatible with existing Surface Mount Techniques
RoHS compliant containing no lead, no bromide and no halogen
MSL1

results in



Multi-vendor compatibility
Easier manufacturing
Environmentally friendly
Increased reliability

Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
V _{DS}	Drain-Source Voltage	30	V
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V	2.7	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V	2.2	A
I _{DM}	Pulsed Drain Current	11	
P _D @ T _A = 25°C	Maximum Power Dissipation	1.3	
P _D @ T _A = 70°C	Maximum Power Dissipation	0.8	W
	Linear Derating Factor	0.01	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
T _J , T _{STG}	Junction and Storage Temperature Range	-55 to + 150	°C

Thermal Resistance

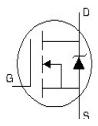
Symbol	Parameter	Typ.	Max.	Units
R _{0JA}	Junction-to-Ambient ③	—	100	°C/W
R _{0JA}	Junction-to-Ambient (t<10s) ④	—	99	

IRML2030TRPbF

Electric Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	30	—	—	V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.03	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	123	154	$\text{m}\Omega$	$V_{GS} = 4.5\text{V}, I_D = 2.2\text{A}$ ②
		—	80	100		$V_{GS} = 10\text{V}, I_D = 2.7\text{A}$ ②
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.3	1.7	2.3	V	$V_{DS} = V_{GS}, I_D = 25\mu\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	—	—	1	μA	$V_{DS} = 24\text{V}, V_{GS} = 0\text{V}$
		—	—	150		$V_{DS} = 24\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20\text{V}$
R_G	Internal Gate Resistance	—	7.6	—	Ω	
g_{fs}	Forward Transconductance	2.6	—	—	S	$V_{DS} = 10\text{V}, I_D = 2.7\text{A}$
Q_g	Total Gate Charge	—	1.0	—	nC	$I_D = 2.7\text{A}$
Q_{gs}	Gate-to-Source Charge	—	0.34	—		$V_{DS} = 15\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	0.34	—		$V_{GS} = 4.5\text{V}$ ②
$t_{d(on)}$	Turn-On Delay Time	—	4.1	—	ns	$V_{DD} = 15\text{V}$ ②
t_r	Rise Time	—	3.3	—		$I_D = 1.0\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	4.5	—		$R_G = 6.8\Omega$
t_f	Fall Time	—	2.9	—		$V_{GS} = 4.5\text{V}$
C_{iss}	Input Capacitance	—	110	—	pF	$V_{GS} = 0\text{V}$
C_{oss}	Output Capacitance	—	29	—		$V_{DS} = 15\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	12	—		$f = 1.0\text{MHz}$

Source - Drain Ratings and Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	1.6	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	11		
V_{SD}	Diode Forward Voltage	—	—	1.0	V	$T_J = 25^\circ\text{C}, I_S = 2.7\text{A}, V_{GS} = 0\text{V}$ ②
t_{rr}	Reverse Recovery Time	—	9.0	14	ns	$T_J = 25^\circ\text{C}, V_R = 15\text{V}, I_F = 2.7\text{A}$
Q_{rr}	Reverse Recovery Charge	—	0.3	0.4	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ②